

Data sheet acquired from Harris Semiconductor SCHS056D – Revised August 2003

## **CMOS OR Gates**

#### High-Voltage Types (20-Volt Rating)

CD4071B Quad 2-Input OR Gate CD4072B Dual 4-Input OR Gate CD4075B Triple 3-Input OR Gate

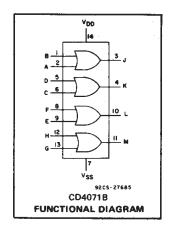
■ CD4071B, CD4072B, and CD4075B OR gates provide the system designer with direct implementation of the positive-logic OR function and supplement the existing family of CMOS gates.

The CD4071B, CD4072B, and CD4075B types are supplied in 14-lead hermetic dual-in-line ceramic packages (F3A suffix), 14-lead dual-in-line plastic packages (E suffix), 14-lead small-outline packages (M, MT, M96, and NSR suffixes), and 14-lead thin shrink small-outline packages (PW and PWR suffixes).

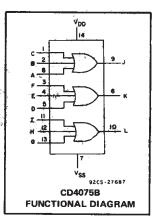
# CD4071B, CD4072B, CD4075B Types

#### Features:

- Medium-Speed Operation-tp<sub>LH</sub>, tp<sub>HL</sub> = 60 ns (typ.) at V<sub>DD</sub> = 10 V
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25 °C
- Standardized, symmetrical output characteristics
- Noise margin (over full package temperature range)
  - 1 V at V<sub>DD</sub> = 5 V
  - 2 V at VDD = 10 V
- 2.5 V at V<sub>DD</sub> = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"



#### V00 14 8 3 C 4 10 13 K W 12 7 VSS 92CS-27696 CD4072B FUNCTIONAL DIAGRAM



#### **RECOMMENDED OPERATING CONDITIONS**

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIN	UNITS	
	MIN.	MAX.	
Supply-Voltage Range (For T <sub>A</sub> = Full Package-Temperature Range)	3	18	٧

#### STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)								
ISTIC	٧o	VIN	VDD					+25		UNITS		
	(\$)	(V)	(V)	-55	-40	+85	+125	Min.	Тур.	Max.	]	
Quiescent Device	-	0,5	5	0.25	0.25	7.5	7.5	_	0.01	0.25		
Current,	-	0,10	10	0.5	0,5	15	15	-	0.01	0.5	_	
IDD Max.	-	0,15	15	1	1	30	30	-	0.01	1	μΑ	
		0,20	20	5	5	150	150	-	0.02	5		
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	-		
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-		
IOL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	_		
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	_	mA	
(Source)	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-		
Current, IOH Min.	9.5	0,10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_		
TOH WIIII.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-		
Output Voltage:	-	0,5	5		0	.05			0	0.05	v	
Low-Level, VOL Max.	_	0,10	10		0	.05		-	0	0.05		
VUL IMAX.	_	0,15	15		0	.05		_	0	0.05		
Output Voltage:		0,5	5		4	.95		4.95	5	-		
High-Level,	_	0,10	10		9	.95		9.95	10	-		
VOH Min.		0,15	15		14	.95		14.95	15	-		
Input Low	0.5, 4.5		. 5		1	.5		_	Γ –	1.5		
Voltage,	1, 9	_	10			3	"	-	_	3		
VIL Max.	1.5,13.5	÷	15			4		_	_	4		
Input High Voltage,	4.5	-	5	_	3	3.5		3.5	-		\ \	
	9	, , ,	10			7		7				
VIH Min.	13.5	_	15		1	1		11	_,	-		
Input Current IJN Max.	e e	0,18	18	±0.1	±0.1	±1	±1	<u>-</u> .	±10 <sup>-5</sup>	±0.1	μА	

# CD4071B, CD4072B, CD4075B Types

MAXIMUM RATINGS, Absolute-Maximum Values:	
DC SUPPLY-VOLTAGE RANGE, (V <sub>DD</sub> )	
Voltages referenced to V <sub>SS</sub> Terminal)	
INPUT VOLTAGE RANGE, ALL INPUTS0.5V to VDD	+0.5V
DC INPUT CURRENT, ANY ONE INPUT±	10mA
POWER DISSIPATION PER PACKAGE (PD):	
For T <sub>A</sub> = -55°C to +190°C	)OmW
For T <sub>A</sub> = +100°C to +125°C	)OmW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	)OmW
OPERATING-TEMPERATURE RANGE (TA)55°C to +1	25°C
STORAGE TEMPERATURE RANGE (T <sub>sto</sub> )65°C to +1	
LEAD TEMPERATURE (DURING SOLDERING):	
At distance 1/16 $\pm$ 1/32 inch (1.59 $\pm$ 0.79mm) from case for 10s max	65°C

# DYNAMIC ELECTRICAL CHARACTERISTICS at T\_A = 25°C, Input t\_r, t\_f = 20 ns, and C\_L = 50 pF, R\_L = 200 $\,k\Omega$

CHARACTERISTIC	TEST COND	TIONS	ALL LIN	UNITS	
		V <sub>DD</sub> VOLTS	TYP.	MAX.	
Propagation Delay Time,  tpHL, tpLH		5 10 15	125 60 45	250 120 90	ns
Transition Time, <sup>t</sup> THL <sup>, t</sup> TLH		5 10 15	100 50 40	200 100 80	ns
Input Capacitance, C <sub>IN</sub>	Any Input	1 – 1	5	7.5	pF

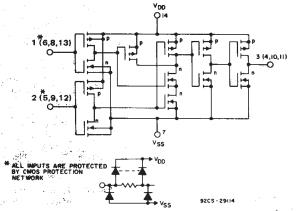


Fig. 3 - Schematic diagram for CD40718 (1 of 4 identical gates).

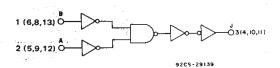


Fig. 5 -/ Logic diagram for CD4071B (1 of 4 identical gates).

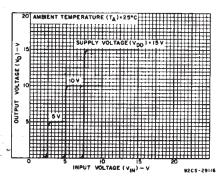


Fig. 1 — Typical voltage transfer characteristics

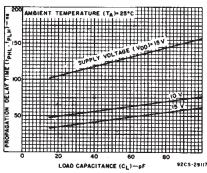


Fig. 2 — Typical propagation delay time as a function of load capacitance.

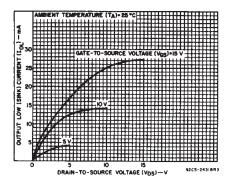


Fig. 4 — Typical output low (sink) current characteristics.

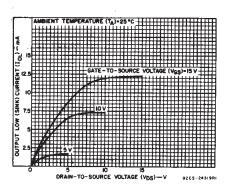
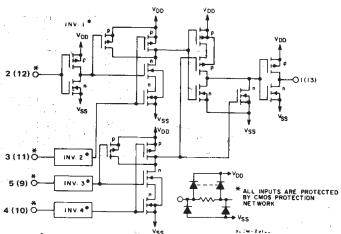


Fig. 6 — Minimum output low (sink) current characteristics.

## CD4071B, CD4072B, CD4075B Types



INVERTERS 2,3 AND 4 ARE IDENTICAL TO INVERTER 1.

Fig. 7 - Schematic diagram for CD4072B (1 of 2 identical gates).

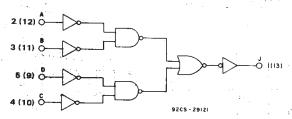


Fig. 9 - Logic diagram for CD4072B (1 of 2 identical gates).

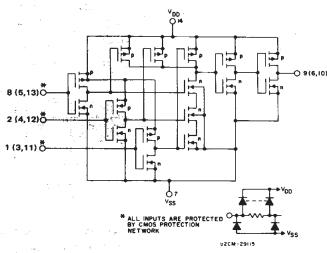


Fig. 11 - Schematic diagram for CD4075B (1 of 3 identical gates).

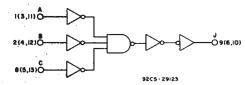


Fig. 13 - Logic diagram for CD4075B (1 of 3 identical gates).

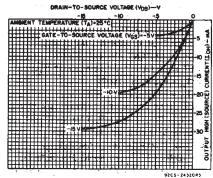


Fig. 8 — Typical output high (source) curren characteristics.

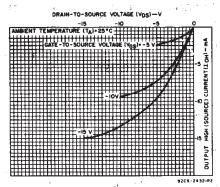


Fig. 10 – Minimum output high (source) current characteristics.

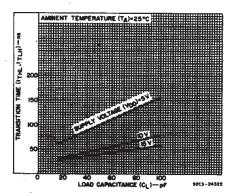


Fig. 12 - Typical transition time as a function of load capacitance.

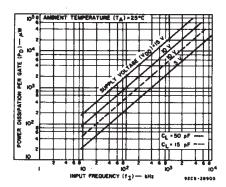
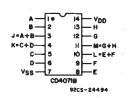
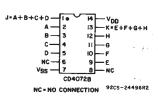


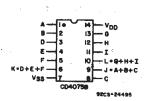
Fig. 14 — Typical dyanamic power dissipation as a function of frequency.

# CD4071B, CD4072B, CD4075B Types

#### **TERMINAL ASSIGNMENTS (TOP VIEW)**







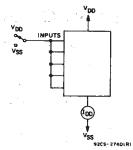


Fig. 15 - Quiescent device current test circuit.

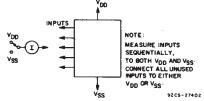


Fig. 16 - Input current test circuit.

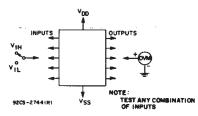
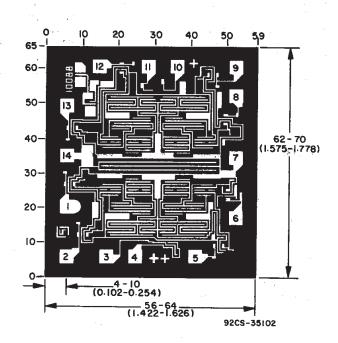
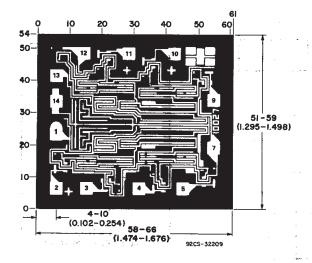


Fig. 17 - Input-voltage test circuit.

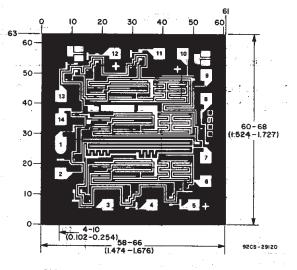
Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10<sup>-3</sup> inch).



Chip dimensions and pad layout for CD4071B.



Chip dimensions and pad layout for CD4072B.



Chip dimensions and pad layout for CD4075B.



28-Feb-2005



## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finis	h MSL Peak Temp <sup>(3)</sup>
7706002CA	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4071BE	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4071BF	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4071BF3A	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4071BM	ACTIVE	SOIC	D	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAI Level-1-235C-UNLIM
CD4071BM96	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAI Level-1-235C-UNLIM
CD4071BMT	ACTIVE	SOIC	D	14	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4071BNSR	ACTIVE	SO	NS	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4071BPW	ACTIVE	TSSOP	PW	14	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4071BPWR	ACTIVE	TSSOP	PW	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4072BE	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4072BF	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4072BF3A	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4072BM	ACTIVE	SOIC	D	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4072BM96	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4072BMT	ACTIVE	SOIC	D	14	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4072BNSR	ACTIVE	SO	NS	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4072BPW	ACTIVE	TSSOP	PW	14	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4072BPWR	ACTIVE	TSSOP	PW	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4075BE	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD4075BF	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4075BF3A	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
CD4075BM	ACTIVE	SOIC	D	14	50	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAF Level-1-235C-UNLIM
CD4075BM96	ACTIVE	SOIC	D	14	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAI Level-1-235C-UNLIM
CD4075BMT	ACTIVE	SOIC	D	14	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAI Level-1-235C-UNLIM
CD4075BNSR	ACTIVE	SO	NS	14	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR Level-1-235C-UNLIM
CD4075BPW	ACTIVE	TSSOP	PW	14	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD4075BPWR	ACTIVE	TSSOP	PW	14	2000	Pb-Free	CU NIPDAU	Level-1-250C-UNLIM



#### PACKAGE OPTION ADDENDUM

28-Feb-2005

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing		ckage Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp (3)
						(RoHS)		
JM38510/17101BCA	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC
JM38510/17103BCA	ACTIVE	CDIP	J	14	1	None	Call TI	Level-NC-NC-NC

<sup>&</sup>lt;sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDSO-G14)

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AB.



### **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



### PW (R-PDSO-G\*\*)

#### 14 PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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